

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/553,292	SCHULZ ET AL.	
Examiner		Art Unit		Page 1 of 1
FATEH M. OBAID		3627		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0130065	09-2002	Bloom, Gregg	209/630
*	B	US-6,601,073	07-2003	Robare, Philip	1/1
*	C	US-2004/0220957	11-2004	McDonough, William	707/102
*	D	US-6,273,267	08-2001	Tamamoto et al.	209/547
*	E	US-2001/0030147	10-2001	Tamamoto et al.	209/547
*	F	US-6,015,039	01-2000	Bonnet, Henri	198/368
*	G	US-2004/0118907	06-2004	Rosenbaum et al.	235/375
*	H	US-4,832,204	05-1989	Handy et al.	209/3.3
*	I	US-2002/0111914	08-2002	Terada et al.	705/60
*	J	US-2005/0149373	07-2005	Amling et al.	705/008
*	K	US-5,971,587	10-1999	Kato et al.	700/115
*	L	US-2007/0102329	05-2007	Rosenbaum et al.	209/584
*	M	US-5,362,949	11-1994	Gulick, Gilbert G.	235/385

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.